Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/684,634	HIRST ET AL.	
Examiner	**Art Unit**	
Ren L. Yan	2854	

SEARCHED			
Class	Subclass	Date	Examiner
399	320 327	8/15/07	RY
	330		
	331		
	21		
361	103		
	200		
	201		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR